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April 1988 Revised February 2004

## 74F779

## 8-Bit Bidirectional Binary Counter with 3-STATE Outputs

## **General Description**

The 74F779 is a fully synchronous 8-stage up/down counter with multiplexed 3-STATE I/O ports for bus-oriented applications. All control functions (hold, count up, count down, synchronous load) are controlled by two mode pins  $(S_0,\,S_1)$ . The device also features carry lookahead for easy cascading. All state changes are initiated by the rising edge of the clock.

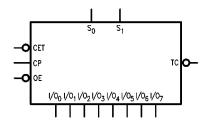
#### **Features**

- Multiplexed 3-STATE I/O ports
- Built-in lookahead carry capability
- Count frequency 100 MHz typ
- Supply current 80 mA typ
- Available in SOIC (300 mil only)

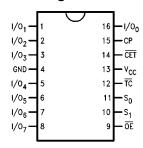
## **Ordering Code:**

| Order Number Package Number Package Description |      |   |  |  |
|---|------|---|--|--|
| 74F779SC  | M16B | 16-Lead Small Outline Intergrated Circuit (SOIC), JEDEC MS-013, 0.300" Wide |  |  |
| 74F779PC  | N16E | 16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide      |  |  |

## **Logic Symbol**



## **Connection Diagram**



## Unit Loading/Fan Out

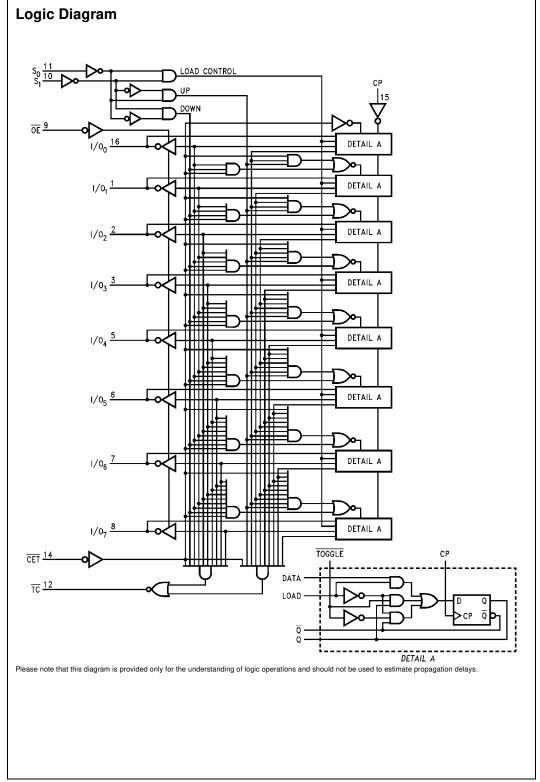
| Din Names                          | Description                             | U.L.         | Input I <sub>IH</sub> /I <sub>IL</sub>  |  |  |
|------------------------------------|---|--------------|---|--|--|
| Pin Names                          | Description                             | HIGH/LOW     | Output I <sub>OH</sub> /I <sub>OL</sub> |  |  |
| I/O <sub>0</sub> –I/O <sub>7</sub> | Data Inputs                             | 0.25/0.33    | 5 μA/–0.2 mA                            |  |  |
|                                    | Data Outputs                            | 75/15 (12.5) | -3 mA/24 mA (20 mA)                     |  |  |
| S <sub>0</sub> , S <sub>1</sub>    | Select Inputs                           | 0.25/0.33    | 5 μA/–0.2 mA                            |  |  |
| ŌĒ                                 | Output Enable Input (Active LOW)        | 0.25/0.33    | 5 μA/–0.2 mA                            |  |  |
| CET                                | Count Enable Trickle Input (Active LOW) | 0.25/0.33    | 5 μA/–0.2 mA                            |  |  |
| CP                                 | Clock Pulse Input (Active Rising Edge)  | 0.25/0.33    | 5 μA/–0.2 mA                            |  |  |
| TC                                 | Terminal Count Output (Active LOW)      | 25/12.5      | -1 mA/20 mA                             |  |  |

## **Function Table**

| S <sub>1</sub> | S <sub>0</sub> | CET | OE | СР | Function                                       |
|----------------|----------------|-----|----|----|--|
| Х              | Х              | Х   | Н  | Х  | I/O <sub>0</sub> to I/O <sub>7</sub> in High Z |
| Х              | X              | Χ   | L  | Χ  | Flip-Flop Outputs Appear on I/O Lines          |
| L              | L              | Χ   | Н  | ~  | Parallel Load All Flip-Flops                   |
| (No            | t LL)          | Н   | X  | ~  | Hold (TC Held HIGH)                            |
| Н              | L              | L   | X  | ~  | Count Up                                       |
| L              | Н              | L   | X  | ~  | Count Down                                     |

H = HIGH Voltage Level
L = LOW Voltage Level
X = Immaterial

= LOW-to-HIGH Clock Transition
(Not LL) means S<sub>0</sub> and S<sub>1</sub> should never both be LOW level at the same time.



## Absolute Maximum Ratings(Note 1)

 $_{to +150^{\circ}C}$  Conditions

-30 mA to +5.0 mA

 $\begin{array}{ll} \mbox{Storage Temperature} & -65\mbox{°C to } +150\mbox{°C} \\ \mbox{Ambient Temperature under Bias} & -55\mbox{°C to } +125\mbox{°C} \\ \end{array}$ 

 $\begin{array}{lll} \mbox{Junction Temperature under Bias} & -55^{\circ}\mbox{C to } +150^{\circ}\mbox{C} \\ \mbox{V}_{CC} \mbox{ Pin Potential to Ground Pin} & -0.5\mbox{V to } +7.0\mbox{V} \\ \mbox{Input Voltage (Note 2)} & -0.5\mbox{V to } +7.0\mbox{V} \\ \end{array}$ 

Input Current ((Note 2)  $\label{eq:Voltage Applied to Output}$  in HIGH State (with V  $_{CC} = 0V$ )

 $\begin{array}{lll} \text{Standard Output} & & -0.5 \text{V to V}_{\text{CC}} \\ \text{3-STATE Output} & & -0.5 \text{V to +5.5V} \end{array}$ 

Current Applied to Output

 $\label{eq:lower_lower} \begin{array}{ll} \text{in LOW State (Max)} & \text{twice the rated I}_{\text{OL}} \ (\text{mA}) \\ \text{ESD Last Passing Voltage (Min)} & 4000 \text{V} \end{array}$ 

Free Air Ambient Temperature 0°C to +70°C Supply Voltage +4.5V to +5.5V

**Recommended Operating** 

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

| Symbol                             | Parameter                    |                     | Min  | Тур | Max  | Units | v <sub>cc</sub> | Conditions  |  |
|------------------------------------|------------------------------|---------------------|------|-----|------|-------|-----------------|---|--|
| V <sub>IH</sub>                    | Input HIGH Voltage           |                     | 2.0  |     |      | V     |                 | Recognized as a HIGH Signal   |  |
| V <sub>IL</sub>                    | Input LOW Voltage            |                     |      |     | 8.0  | V     |                 | Recognized as a LOW Signal  |  |
| V <sub>CD</sub>                    | Input Clamp Diode Voltage    |                     |      |     | -1.2 | V     | Min             | $I_{IN} = -18 \text{ mA}$   |  |
| V <sub>OH</sub>                    | Output HIGH                  | 10% V <sub>CC</sub> | 2.4  |     |      | V     | Min             | I <sub>OH</sub> = -3 mA   |  |
|                                    | Voltage                      | $5\% V_{CC}$        | 2.7  |     |      | v     | IVIIII          | 10H = -3 IIIA   |  |
| V <sub>OL</sub>                    | Output LOW                   | 10% V <sub>CC</sub> |      |     | 0.5  | V     | Min             | I <sub>OL</sub> = 20 mA   |  |
|                                    | Voltage                      | 5% V <sub>CC</sub>  |      |     | 0.5  | V     | IVIII           | $I_{OL} = 20 \text{ mA}$  |  |
| I <sub>IH</sub>                    | Input HIGH Current           |                     |      |     | 5.0  | μΑ    | Max             | V <sub>IN</sub> = 2.7V (Non-I/O Pins)                                   |  |
| I <sub>BVI</sub>                   | Input HIGH Current           |                     |      |     | 7.0  | μА    | Max             | V <sub>IN</sub> = 7.0V (Non-I/O Pins)                                   |  |
|                                    | Breakdown Test               |                     |      |     | 7.0  | μΑ    | IVIAX           | V <sub>IN</sub> = 7.0V (NOII-1/O FILIS)                                 |  |
| I <sub>BVIT</sub>                  | Input HIGH Current           |                     |      |     | 0.5  | mA    | Max             | V <sub>IN</sub> = 5.5V (I/O <sub>n</sub> )                              |  |
|                                    | Breakdown (I/O)              |                     |      |     | 0.5  | IIIA  | IVIAX           | $\mathbf{v}_{\text{IN}} = 5.5 \mathbf{v} \left( 1/O_{\text{n}} \right)$ |  |
| I <sub>CEX</sub>                   | Output HIGH                  |                     |      |     | 50   | ^     | Max             | V <sub>OLIT</sub> = V <sub>CC</sub>                                     |  |
|                                    | Leakage Current              |                     |      |     | 50   | μА    | IVIAX           | V <sub>OUT</sub> = V <sub>CC</sub>                                      |  |
| $V_{ID}$                           | Input Leakage                |                     | 4.75 |     |      | V     | 0.0             | $I_{ID} = 1.9 \mu A$  |  |
|                                    | Test                         |                     | 4.73 |     |      | V     | 0.0             | All other pins grounded   |  |
| I <sub>OD</sub>                    | Output Leakage               |                     |      |     | 3.75 | μА    | 0.0             | V <sub>IOD</sub> = 150 mV   |  |
|                                    | Circuit Current              |                     |      |     | 3.73 | μΛ    | 0.0             | All other pins grounded   |  |
| I <sub>ZZ</sub>                    | Bus Drainage Test            |                     |      |     | 500  | μΑ    | 0.0             | V <sub>OUT</sub> = 5.25V  |  |
| I <sub>IL</sub>                    | Input LOW Current            |                     |      |     | -0.2 | mA    | Max             | V <sub>IN</sub> = 0.5V (Non I/O Pins)                                   |  |
| I <sub>IH</sub> + I <sub>OZH</sub> | Output Leakage Current       |                     |      |     | 70   | μΑ    | Max             | $V_{OUT} = 2.7V (I/O_n)$  |  |
| I <sub>IL</sub> + I <sub>OZL</sub> | Output Leakage Current       |                     |      |     | -200 | μΑ    | Max             | $V_{OUT} = 0.5V (I/O_n)$  |  |
| los                                | Output Short-Circuit Current |                     | -60  |     | -150 | mA    | Max             | $V_{OUT} = 0V$  |  |
| I <sub>CCH</sub>                   | Power Supply Current         |                     |      |     | 90   | mA    | Max             | V <sub>O</sub> = HIGH   |  |
| I <sub>CCL</sub>                   | Power Supply Current         |                     |      |     | 105  | mA    | Max             | $V_O = LOW$   |  |
| I <sub>CCZ</sub>                   | Power Supply Current         |                     |      |     | 110  | mA    | Max             | V <sub>O</sub> = HIGH Z   |  |

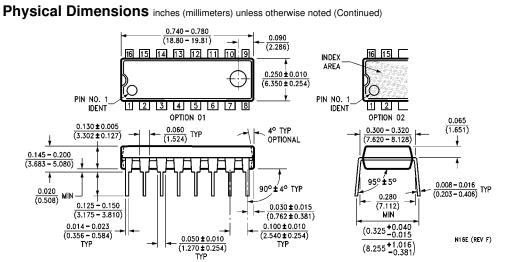
## **AC Electrical Characteristics**

| Symbol           | Parameter               | $T_A = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$ |     |      | $T_A = 0^{\circ}C \text{ to } +70^{\circ}C$ $V_{CC} = +5.0V$ $C_L = 50 \text{ pF}$ |      | Units |  |
|------------------|-------------------------|---|-----|------|--|------|-------|--|
|                  |                         | Min   | Тур | Max  | Min  | Max  |       |  |
| f <sub>MAX</sub> | Maximum Clock Frequency | 100   | 105 |      | 90   |      |       |  |
| t <sub>PLH</sub> | Propagation Delay       | 3.0   | 5.0 | 8.0  | 3.0  | 8.5  | ns    |  |
| t <sub>PHL</sub> | CP to I/O <sub>n</sub>  | 5.0   | 7.5 | 11.0 | 5.0  | 11.0 | 115   |  |
| t <sub>PLH</sub> | Propagation Delay       | 5.0   | 7.5 | 9.0  | 5.0  | 10.0 | ns    |  |
| t <sub>PHL</sub> | CP to TC                | 5.0   | 9.3 | 10.5 | 5.0  | 11.5 | ris   |  |
| t <sub>PLH</sub> | Propagation Delay       | 2.5   | 3.8 | 5.5  | 2.5  | 6.0  | ns    |  |
| t <sub>PHL</sub> | CET to TC               | 4.5   | 6.1 | 8.0  | 4.5  | 8.5  | 115   |  |
| t <sub>PLH</sub> | Propagation Delay       | 3.5   | 6.5 | 12.0 | 3.5  | 13.0 | no    |  |
| t <sub>PHL</sub> | SN to TC                | 3.5   | 7.5 | 12.0 | 3.5  | 13.0 | ns    |  |
| t <sub>PZH</sub> | Output Enable Time      | 3.0   | 5.0 | 7.0  | 3.0  | 8.0  | ns    |  |
| t <sub>PZL</sub> | OE to I/O <sub>n</sub>  | 5.0   | 8.0 | 10.0 | 5.0  | 10.5 | 115   |  |
| t <sub>PHZ</sub> | Output Disable Time     | 1.0   | 4.0 | 6.5  | 1.0  | 7.0  | ns    |  |
| t <sub>PLZ</sub> | OE to I/O <sub>n</sub>  | 1.0   | 3.7 | 6.5  | 1.0  | 7.0  | 115   |  |

## **AC Operating Requirements**

|                    | Parameter              | T <sub>A</sub> = +25°C                |     | T <sub>A</sub> = 0°C to +70°C |     | Units |  |
|--------------------|------------------------|---------------------------------------|-----|-------------------------------|-----|-------|--|
| Symbol             |                        | $\text{V}_{\text{CC}} = +5.0\text{V}$ |     | $V_{CC} = +5.0V$              |     |       |  |
|                    |                        | Min                                   | Max | Min                           | Max |       |  |
| t <sub>S</sub> (H) | Setup Time             | 5.0                                   |     | 5.0                           |     | ns    |  |
| t <sub>S</sub> (L) | I/O <sub>n</sub> to CP | 5.0                                   |     | 5.0                           |     | 115   |  |
| t <sub>H</sub> (H) | Hold Time              | 0.0                                   |     | 0.0                           |     | ns    |  |
| t <sub>H</sub> (L) | I/O <sub>n</sub> to CP | 0.0                                   |     | 0.0                           |     | 115   |  |
| t <sub>S</sub> (H) | Setup Time             | 9.5                                   |     | 10.0                          |     | ns    |  |
| t <sub>S</sub> (L) | S <sub>n</sub> to CP   | 9.5                                   |     | 10.0                          |     | IIS   |  |
| t <sub>H</sub> (H) | Hold Time              | 0.0                                   |     | 0.0                           |     | ns    |  |
| t <sub>H</sub> (L) | S <sub>n</sub> to CP   | 0.0                                   |     | 0.0                           |     | 115   |  |
| t <sub>S</sub> (H) | Setup Time             | 7.0                                   |     | 7.0                           |     | ns    |  |
| t <sub>S</sub> (L) | CET to CP              | 7.0                                   |     | 7.0                           |     | 115   |  |
| t <sub>H</sub> (H) | Hold Time              | 0.0                                   |     | 0.0                           |     | ns    |  |
| t <sub>H</sub> (L) | CET to CP              | 0.0                                   |     | 0.0                           |     | 115   |  |
| t <sub>W</sub> (H) | Clock Pulse Width      | 4.0                                   |     | 4.0                           |     | ns    |  |
| t <sub>W</sub> (L) | HIGH or LOW            | 4.0                                   |     | 4.0                           |     | 115   |  |

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16-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300" Wide Package Number N16E

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